

### SLOVENSKI STANDARD SIST EN IEC 62391-1:2023

01-januar-2023

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## Nespremenljivi električni dvoplastni kondenzatorji za električno in elektronsko opremo - 1. del: Rodovna specifikacija (IEC 62391-1:2022)

Fixed electric double-layer capacitors for use in electric and electronic equipment - Part 1: Generic specification (IEC 62391-1:2022)

Elektrische Doppelschichtkondensatoren zur Verwendung in elektrischen und elektronischen Geräten - Teil 1: Fachgrundspezifikation (IEC 62391-1:2022)

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Condensateurs électriques fixes à double couche utilisé dans les équipements électriques et électroniques - Partie 1: Spécification générique (IEC 62391-1:2022)

Ta slovenski standard je istoveten z: EN IEC 62391-1:2022

ICS:

31.060.10 Fiksni kondenzatorji

**Fixed capacitors** 

SIST EN IEC 62391-1:2023

en

SIST EN IEC 62391-1:2023

## iTeh STANDARD PREVIEW (standards.iteh.ai)

SIST EN IEC 62391-1:2023 https://standards.iteh.ai/catalog/standards/sist/2f1ed401-11c1-46c3-acd4-524892425e7c/sist-en-iec-62391-1-2023

## EUROPEAN STANDARD NORME EUROPÉENNE EUROPÄISCHE NORM

### EN IEC 62391-1

November 2022

ICS 31.060.10

Supersedes EN 62391-1:2016; EN 62391-1:2016/AC:2016-12; EN 62391-1:2016/AC:2019-08

**English Version** 

### Fixed electric double-layer capacitors for use in electric and electronic equipment - Part 1: Generic specification (IEC 62391-1:2022)

Condensateurs électriques fixes à double couche utilisés dans les équipements électriques et électroniques - Partie 1: Spécification générique (IEC 62391-1:2022) Elektrische Doppelschichtkondensatoren zur Verwendung in elektrischen und elektronischen Geräten - Teil 1: Fachgrundspezifikation (IEC 62391-1:2022)

This European Standard was approved by CENELEC on 2022-11-24. CENELEC members are bound to comply with the CEN/CENELEC Internal Regulations which stipulate the conditions for giving this European Standard the status of a national standard without any alteration.

Up-to-date lists and bibliographical references concerning such national standards may be obtained on application to the CEN-CENELEC Management Centre or to any CENELEC member.

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CEN-CENELEC Management Centre: Rue de la Science 23, B-1040 Brussels

### European foreword

The text of document 40/2966/FDIS, future edition 3 of IEC 62391-1, prepared by IEC/TC 40 "Capacitors and resistors for electronic equipment" was submitted to the IEC-CENELEC parallel vote and approved by CENELEC as EN IEC 62391-1:2022.

The following dates are fixed:

- latest date by which the document has to be implemented at national (dop) 2023-08-24 level by publication of an identical national standard or by endorsement
- latest date by which the national standards conflicting with the (dow) 2025-11-24 document have to be withdrawn

This document supersedes EN 62391-1:2016 and all of its amendments and corrigenda (if any).

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The text of the International Standard IEC 62391-1:2022 was approved by CENELEC as a European Standard without any modification.

In the official version, for Bibliography, the following notes have to be added for the standard indicated:

- IEC 60027 (series) NOTE Harmonized as EN 60027 (series)
- IEC 60068-2-47:2005 NOTE Harmonized as EN 60068-2-47:2005 (not modified)
- IEC 60301:2012 NOTE Harmonized as EN 60301:2012 (not modified)
- IEC 60384-1:2021 NOTE Harmonized as EN IEC 60384-1:2021 (not modified)

IEC 60695-2-11 NOTE Harmonized as EN IEC 60695-2-11

IEC 61881-3:2012 NOTE Harmonized as EN 61881-3:2012 (not modified)

- IEC 62391-1:2015 NOTE Harmonized as EN 62391-1:2016 (not modified)
- IEC 62391-2:2006 NOTE Harmonized as EN 62391-2:2006 (not modified)
- IEC 62391-2-1:2006 NOTE Harmonized as EN 62391-2-1:2006 (not modified)
- IEC 62576:2018 NOTE Harmonized as EN IEC 62576:2018 (not modified)
- ISO 80000-1:2009 NOTE Harmonized as EN ISO 80000-1:2013 (not modified)

## **Annex ZA** (normative)

## Normative references to international publications with their corresponding European publications

The following documents are referred to in the text in such a way that some or all of their content constitutes requirements of this document. For dated references, only the edition cited applies. For undated references, the latest edition of the referenced document (including any amendments) applies.

NOTE 1 Where an International Publication has been modified by common modifications, indicated by (mod), the relevant EN/HD applies.

NOTE 2 Up-to-date information on the latest versions of the European Standards listed in this annex is available here: <u>www.cenelec.eu</u>.

Publication	Year	Title	<u>EN/HD</u>	Year
IEC 60062	-	Marking codes for resistors and capacitors	EN 60062	-
IEC 60063	-	Preferred number series for resistors and capacitors	EN 60063	-
IEC 60068-1	2013	Environmental testing - Part 1: General and guidance	EN 60068-1	2014
IEC 60068-2-1	2007	Environmental testing - Part 2-1: Tests - Test A: Cold	EN 60068-2-1	2007
IEC 60068-2-2	2007 standard	Environmental testing - Part 2-2: Tests - Test B: Dry heat	EN 60068-2-2	2007
IEC 60068-2-6	-	Environmental testing - Part 2-6: Tests - 2 Test Fc: Vibration (sinusoidal)		-
IEC 60068-2-14	-	Environmental testing - Part 2-14: Tests - Test N: Change of temperature	EN 60068-2-14	-
IEC 60068-2-20	-	Environmental testing - Part 2-20: Tests - Test Ta and Tb: Test methods for solderability and resistance to soldering heat of devices with leads	EN IEC 60068-2-20	) -
IEC 60068-2-21	-	Environmental testing - Part 2-21: Tests - Test U: Robustness of terminations and integral mounting devices	EN IEC 60068-2-2	1 -
IEC 60068-2-45	1980	Basic environmental testing procedures - Part 2-45: Tests - Test XA and guidance: Immersion in cleaning solvents	EN 60068-2-45	1992
+ A1	1993		+ A1	1993
IEC 60068-2-58	-	Environmental testing - Part 2-58: Tests - Test Td: Test methods for solderability, resistance to dissolution of metallization and to soldering heat of surface mounting devices (SMD)	EN 60068-2-58	-

### SIST EN IEC 62391-1:2023

### EN IEC 62391-1:2022 (E)

IEC 60068-2-69	-	Environmental testing - Part 2-69: Tests - Test Te/ Tc: Solderability testing of electronic components and printed boards by the wetting balance (force measurement) method	EN 60068-2-69	-
IEC 60068-2-78	-	Environmental testing - Part 2-78: Tests - Test Cab: Damp heat, steady state	EN 60068-2-78	-
IEC 60294	-	Measurement of the dimensions of a cylindrical component with axial terminations	EN 60294	-
IEC 60695-11-5	-	Fire hazard testing - Part 11-5: Test flames - Needle-flame test method - Apparatus, confirmatory test arrangement and guidance	EN 60695-11-5	-
IEC 60717	-	Method for the determination of the space required by capacitors and resistors with unidirectional terminations	EN 60717	-
IEC 61193-2	-	Quality assessment systems - Part 2: Selection and use of sampling plans for inspection of electronic components and packages	EN 61193-2	-

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Edition 3.0 2022-10

# INTERNATIONAL STANDARD

# NORME INTERNATIONALE



Fixed electric double-layer capacitors for use in electric and electronic equipment – Part 1: Generic specification

Condensateurs électriques fixes à double couche utilisés dans les équipements électriques et électroniques – talog/standards/sist/211ed401-111e1-46c3-acd4-Partie 1: Spécification générique<sup>7c/sist-en-lec-62391-1-2023</sup>

INTERNATIONAL ELECTROTECHNICAL COMMISSION

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### INTERNATIONAL ELECTROTECHNICAL COMMISSION

### FIXED ELECTRIC DOUBLE-LAYER CAPACITORS FOR USE IN ELECTRIC AND ELECTRONIC EQUIPMENT –

### Part 1: Generic specification

### FOREWORD

- 1) The International Electrotechnical Commission (IEC) is a worldwide organization for standardization comprising all national electrotechnical committees (IEC National Committees). The object of IEC is to promote international co-operation on all questions concerning standardization in the electrical and electronic fields. To this end and in addition to other activities, IEC publishes International Standards, Technical Specifications, Technical Reports, Publicly Available Specifications (PAS) and Guides (hereafter referred to as "IEC Publication(s)"). Their preparation is entrusted to technical committees; any IEC National Committee interested in the subject dealt with may participate in this preparatory work. International, governmental and non-governmental organizations liaising with the IEC also participate in this preparation. IEC collaborates closely with the International Organization for Standardization (ISO) in accordance with conditions determined by agreement between the two organizations.
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IEC 62391-1 has been prepared by IEC technical committee 40: Capacitors and resistors for electronic equipment. It is an International Standard.

This third edition cancels and replaces the second edition published in 2015. This edition constitutes a technical revision.

This edition includes the following significant technical changes with respect to the previous edition:

- a) The document has been completely restructured to comply with the ISO/IEC Directives, Part 2; a new technical categorization of test methods has been introduced and the test methods have been reorganized according to these new categories; tables, figures and references have been revised accordingly.
- b) Calculation formula of charging/discharging efficiency in Annex D were divided into two cases: "Calculation assuming full charge and discharge" and "Calculation assuming incomplete charging and discharging due to internal resistance".

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The text of this International Standard is based on the following documents:

Draft	Report on voting
40/2966/FDIS	40/2976/RVD

Full information on the voting for its approval can be found in the report on voting indicated in the above table.

The language used for the development of this International Standard is English.

A list of all parts in the IEC 62391 series, published under the general title *Fixed electric double-layer capacitors for use in electric and electronic equipment*, can be found on the IEC website.

This document was drafted in accordance with ISO/IEC Directives, Part 2, and developed in accordance with ISO/IEC Directives, Part 1 and ISO/IEC Directives, IEC Supplement, available at www.iec.ch/members\_experts/refdocs. The main document types developed by IEC are described in greater detail at www.iec.ch/standardsdev/publications.

The committee has decided that the contents of this document will remain unchanged until the stability date indicated on the IEC website under webstore.iec.ch in the data related to the specific document. At this date, the document will be

- reconfirmed,
- withdrawn,
- replaced by a revised edition, or
- amended.

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### FIXED ELECTRIC DOUBLE-LAYER CAPACITORS FOR USE IN ELECTRIC AND ELECTRONIC EQUIPMENT –

### Part 1: Generic specification

#### 1 Scope

This part of IEC 62391 applies to fixed electric double-layer capacitors (hereafter referred to as capacitors) mainly used in DC circuits of electric and electronic equipment.

This part of IEC 62391 establishes standard terms, inspection procedures and methods of test for use in sectional and detail specifications of electronic components for quality assessment or any other purpose.

#### 2 Normative references

The following documents are referred to in the text in such a way that some or all of their content constitutes requirements of this document. For dated references, only the edition cited applies. For undated references, the latest edition of the referenced document (including any amendments) applies.

IEC 60062, Marking codes for resistors and capacitors

IEC 60063, Preferred number series for resistors and capacitors

IEC 60068-1:2013, Environmental testing – Part 1: General and guidance

IEC 60068-2-1:2007, Environmental testing – Part 2-1: Tests – Tests A: Cold

IEC 60068-2-2:2007, Environmental testing – Part 2-2: Tests – Tests B: Dry Heat

IEC 60068-2-6, Environmental testing – Part 2-6: Tests – Test Fc: Vibration (sinusoidal)

IEC 60068-2-14, Environmental testing – Part 2-14: Tests – Test N: Change of temperature

IEC 60068-2-20, Environmental testing – Part 2-20: Tests – Test Ta and Tb: Test methods for solderability and resistance to soldering heat of devices of with leads

IEC 60068-2-21, Environmental testing – Part 2-21: Tests – Test U: Robustness of terminations and integral mounting devices

IEC 60068-2-45:1980, Environmental testing – Part 2-45: Tests – Test XA and guidance: Immersion in cleaning solvents IEC 60068-2-45:1980/AMD1:1993)

IEC 60068-2-58, Environmental testing – Part 2-58: Tests – Test Td: Test methods for solderability, resistance to dissolution of metallization and to soldering heat of surface mounting devices (SMD)

IEC 60068-2-69, Environmental testing – Part 2-69: Tests – Test Te/ Tc: Solderability testing of electronic components and printed boards by the wetting balance (force measurement) method